


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/389,299	KOBAYASHI ET AL.	
	Examiner	Art Unit	
	Christian La Forgia	2131	

SEARCHED			
Class	Subclass	Date	Examiner
358	1.*	4/7/2006	CLF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search IEEE Search ACM Search Google Search	4/7/2006	CLF